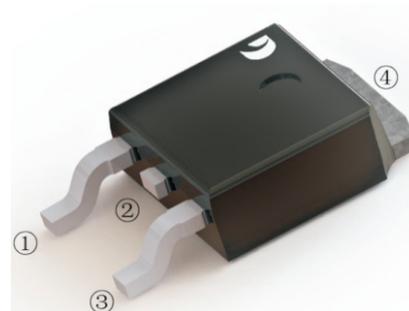


**80A, 30V N-CHANNEL  
POWER MOSFET**

**TO-252W**

**DESCRIPTION**

D3R6N30 is an N-channel enhanced MOS field effect transistor. Advanced technology and cell structure make the product. It has low on resistance, excellent switching performance and High avalanche breakdown withstand voltage. The product can be widely used in uninterruptible power supply and Power management field of inverter system.



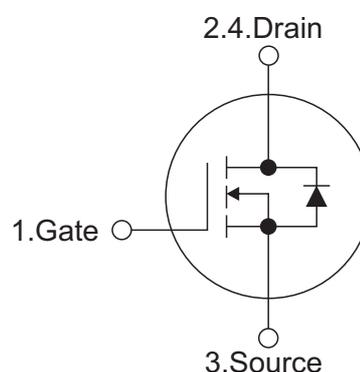
**Features**

- $R_{DS(ON)(TYP)} 3.6m\ \Omega @ V_{GS}=10V, I_D=20A$
- Fast switching capability
- Avalanche energy tested
- Improved dv/dt capability, high ruggedness
- Low gate drive voltage

**Mechanical data**

- Case: TO-252W
- Approx. Weight: 0.315g (0.011oz)
- Lead free finish, RoHS compliant
- Case Material: "Green" molding compound, UL flammability classification 94V-0, "Halogen-free".

**SYMBOL**



**ABSOLUTE MAXIMUM RATINGS (TA=25°C, unless otherwise specified)**

PARAMETER	Symbols	RATINGS	Units	
Drain-Source Voltage	$V_{DSS}$	30	V	
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V	
Continuous Drain Current	$I_D$	$T_c=25^\circ C$	80	A
		$T_c=100^\circ C$	57	A
Pulsed Drain Current (Note 2)	$I_{DM}$	320	A	
Avalanche Energy Single Pulsed (Note 3)	$E_{AS}$	144	mJ	
Peak Diode Recovery dv/dt (Note 4)	dv/dt	2.1	V/ns	
Power Dissipation	$P_D$	82	W	
Operation Junction Temperature and Storage Temperature	$T_j, T_{stg}$	-55 ~ +150	$^\circ C$	

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.  
 2. Repetitive Rating: Pulse width limited by maximum junction temperature.  
 3.  $L = 0.5mH, I_{AS} = 24A, V_{DD} = 50V, R_G = 25\ \Omega, \text{Starting } T_J = 25^\circ C$   
 4.  $ISD \leq 80A, di/dt \leq 200A/\mu s, V_{DD} \leq BVDSS, \text{Starting } T_J = 25^\circ C$

**THERMAL DATA**

PARAMETER	Symbols	RATINGS	Units
Junction to Ambient	$R_{thJA}$	63	$^\circ C/W$
Junction to Case	$R_{thJC}$	1.52	$^\circ C/W$



ELECTRICAL CHARACTERISTICS (TA=25°C, unless otherwise specified)

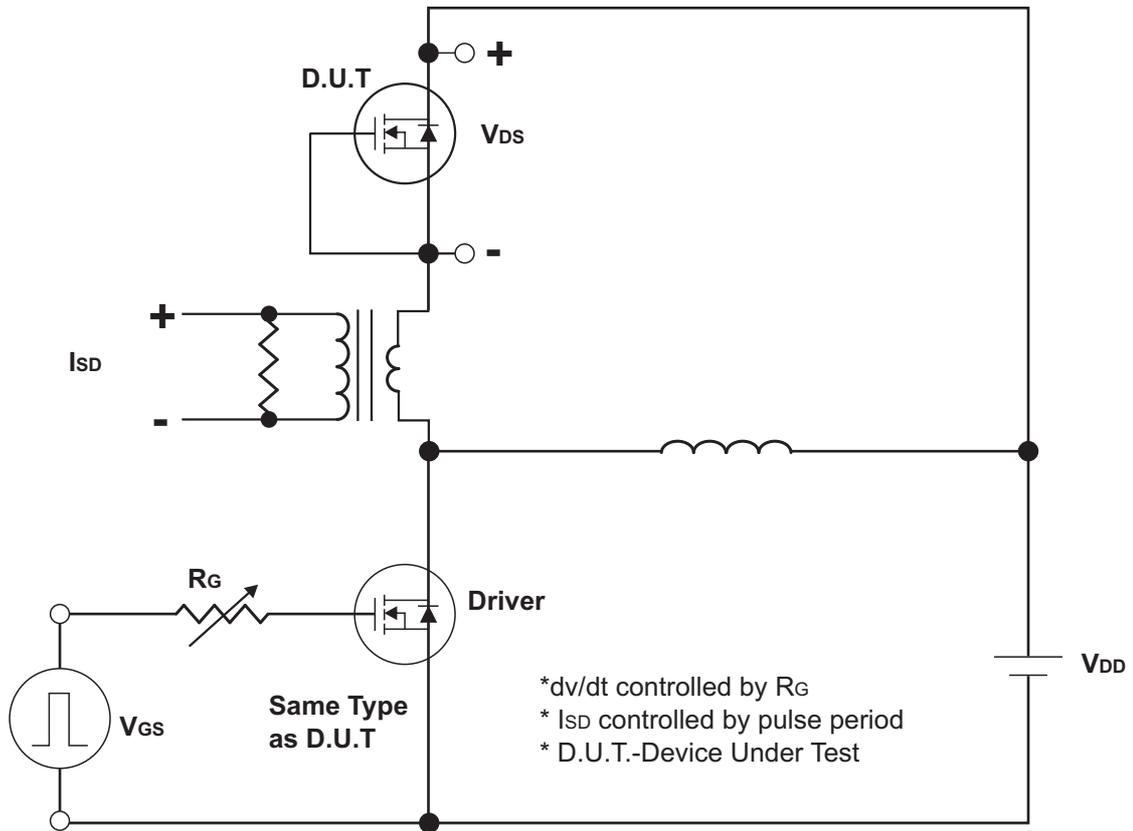
PARAMETER		Symbols	TEST CONDITIONS	Min	Typ	Max	Units	
<b>OFF CHARACTERISTICS</b>								
Drain-Source Breakdown Voltage		$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	30			V	
Drain-Source Leakage Current		$I_{DSS}$	$V_{DS}=30V, V_{GS}=0V$			1	$\mu A$	
Gate- Source Leakage Current	Forward	$I_{GSS}$	$V_{GS}=20V, V_{DS}=0V$			100	nA	
	Reverse		$V_{GS}=-20V, V_{DS}=0V$			-100		
<b>ON CHARACTERISTICS</b>								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.2	1.5	2.5	V	
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$		3.6		m $\Omega$	
<b>DYNAMIC CHARACTERISTICS</b>								
Input Capacitance		$C_{ISS}$	$V_{DS}=25V,$ $V_{GS}=0V,$ $f=1.0MHz$		2414		pF	
Output Capacitance		$C_{OSS}$				268		pF
Reverse Transfer Capacitance		$C_{RSS}$				206		pF
<b>SWITCHING CHARACTERISTICS</b>								
Total Gate Charge (Note 1)		$Q_G$	$V_{DS}=24V, V_{GS}=10V,$ $I_D=80A, I_G=1mA$ (NOTE1,2)		13		nC	
Gate-Source Charge		$Q_{GS}$				4		nC
Gate-Drain Charge		$Q_{GD}$				2.2		nC
Turn-On Delay Time (Note 1)		$t_{D(ON)}$	$V_{DS}=15V, V_{GS}=10V,$ $I_D=80A, R_G=25\Omega$ (NOTE1,2)		7		ns	
Turn-On Rise Time		$t_R$				16		ns
Turn-Off Delay Time		$t_{D(OFF)}$				36		ns
Turn-Off Fall Time		$t_F$				22		ns
<b>DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS</b>								
Maximum Body-Diode Continuous Current		$I_S$				80	A	
Maximum Body-Diode Pulsed Current		$I_{SM}$				320	A	
Drain-Source Diode Forward Voltage (Note 1)		$V_{SD}$	$I_S=40A, V_{GS}=0V$			1.4	V	
Reverse Recovery Time (Note 1)		$t_{rr}$	$I_S=40A, V_{GS}=0V,$		250		ns	
Reverse Recovery Charge		$Q_{rr}$	$di/dt=100A/\mu s$		4.5		$\mu C$	

Notes:

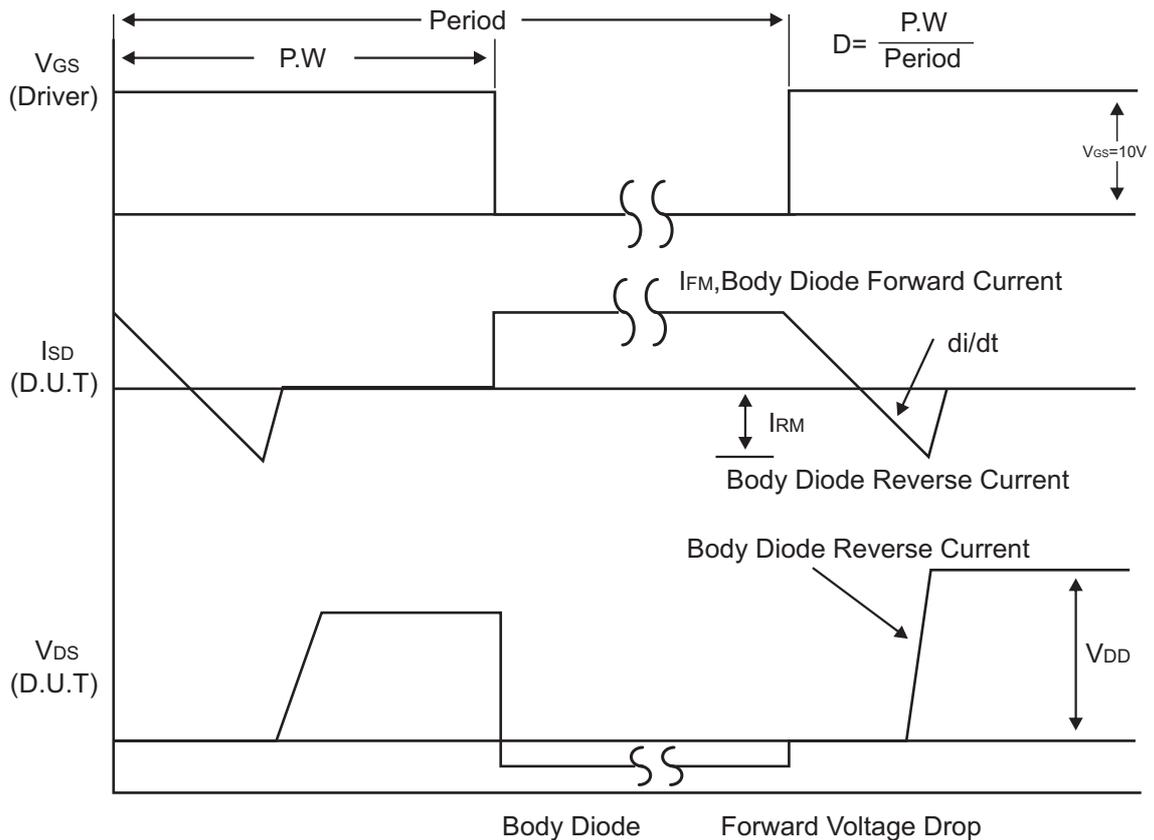
1. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ .
2. Essentially independent of operating temperature.



Test Circuits and waveforms



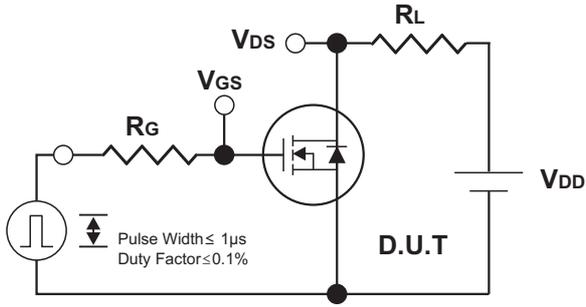
Peak Diode Recovery dv/dt Test Circuit



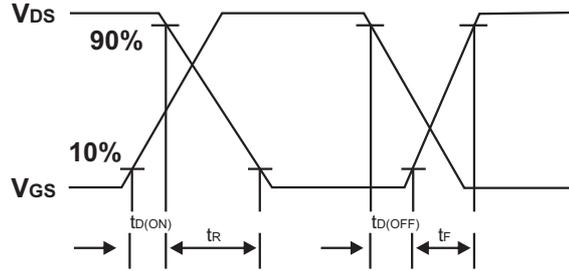
Peak Diode Recovery dv/dt Waveforms



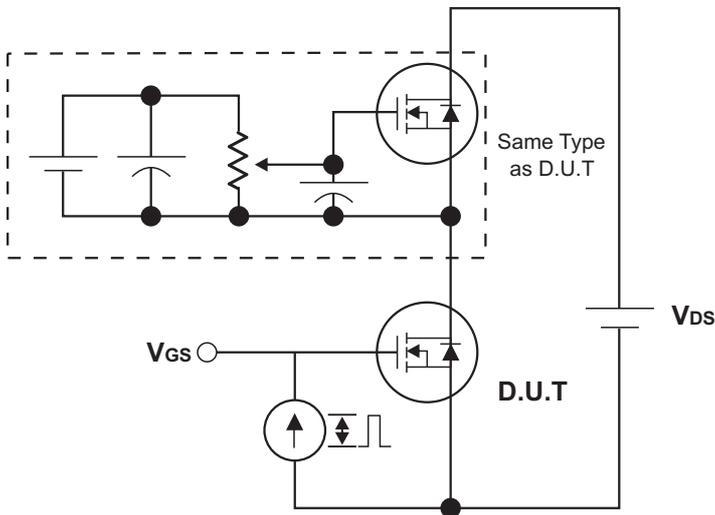
### Test Circuits and waveforms



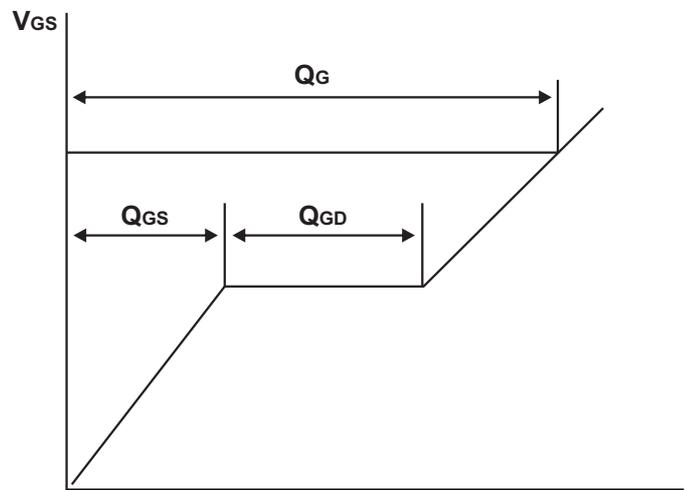
Switching Test Circuit



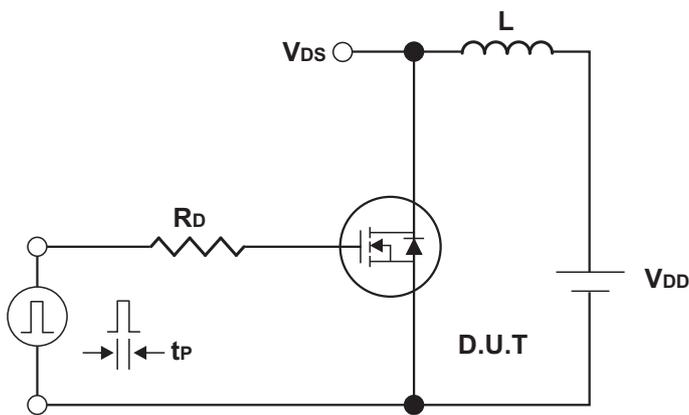
Switching Waveforms



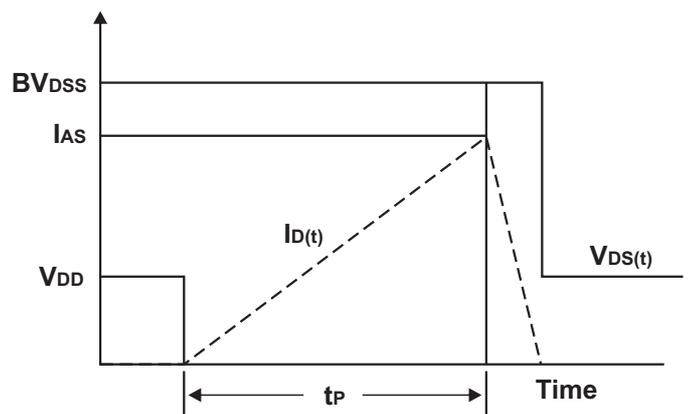
Gate Charge Test Circuit



Charge  
Gate Charge Waveform



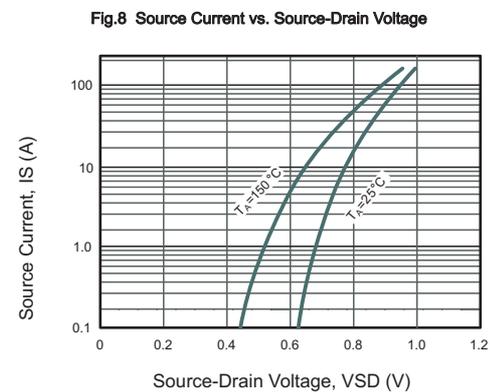
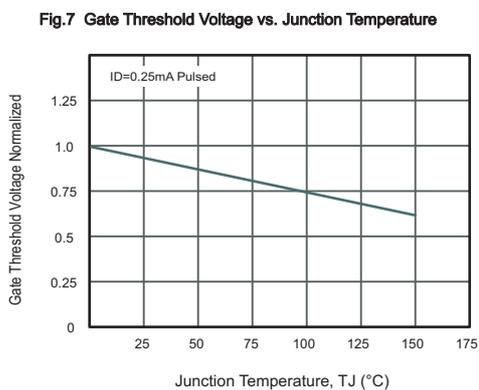
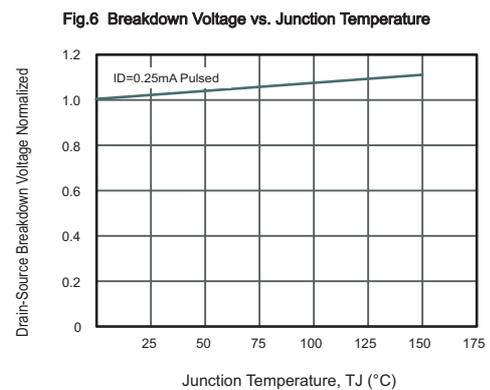
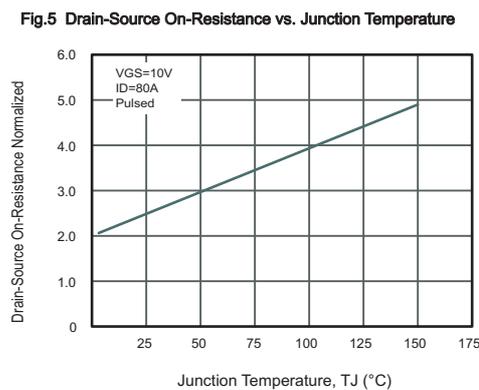
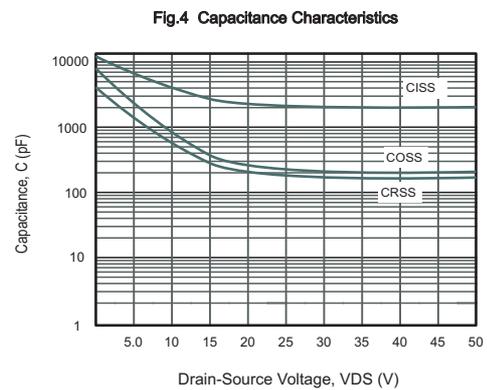
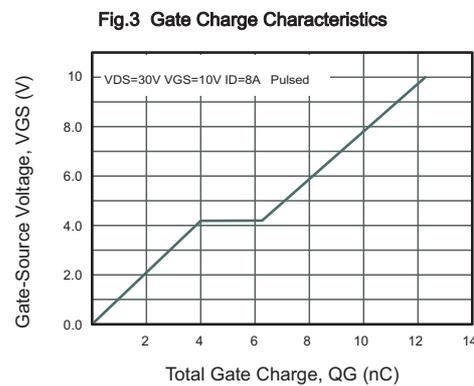
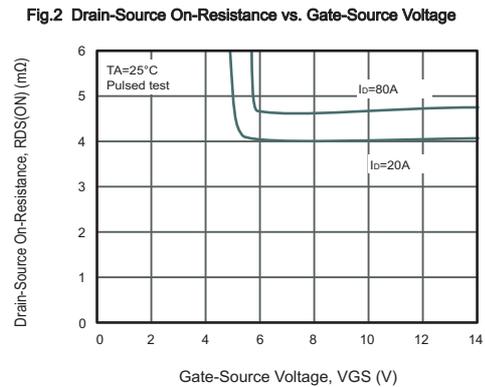
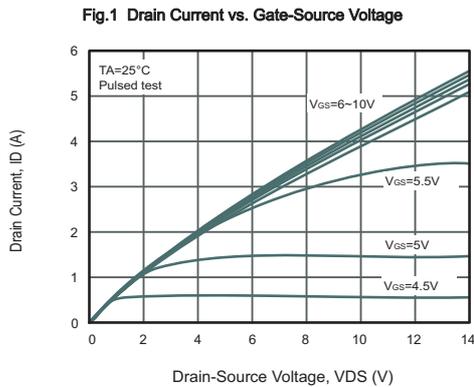
Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms



### Typical Characteristics





## Typical Characteristics

Fig.9 Drain Current vs. Gate-Source Voltage

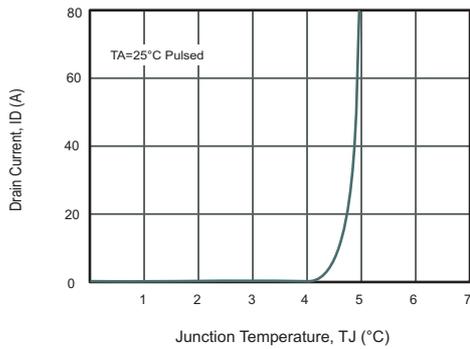


Fig.10 Drain-Source On-Resistance vs. Drain Current

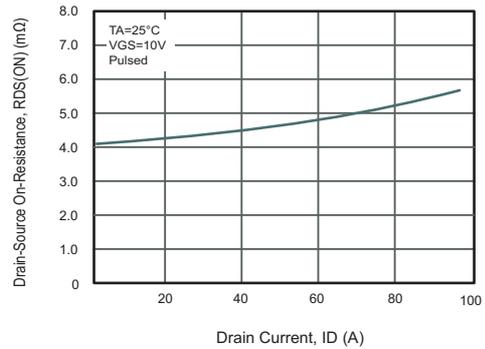


Fig.11 Drain Current vs. Junction Temperature

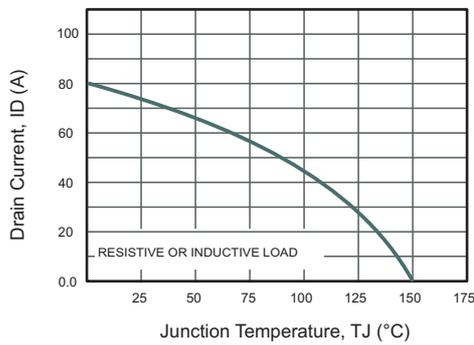


Fig.12 Power Dissipation vs. Junction Temperature

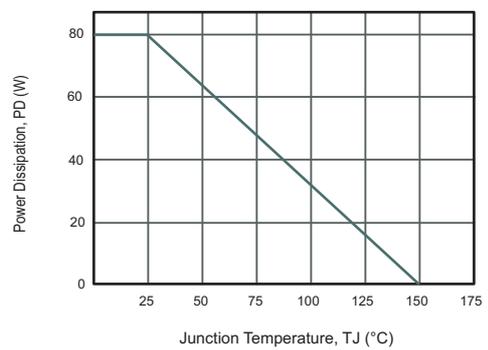
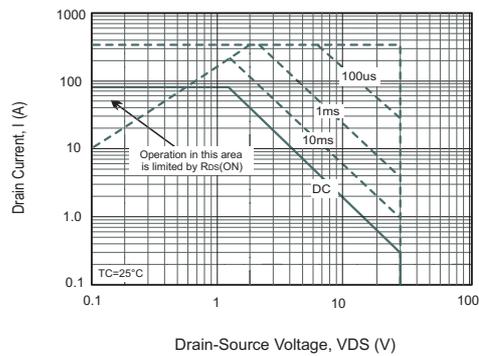
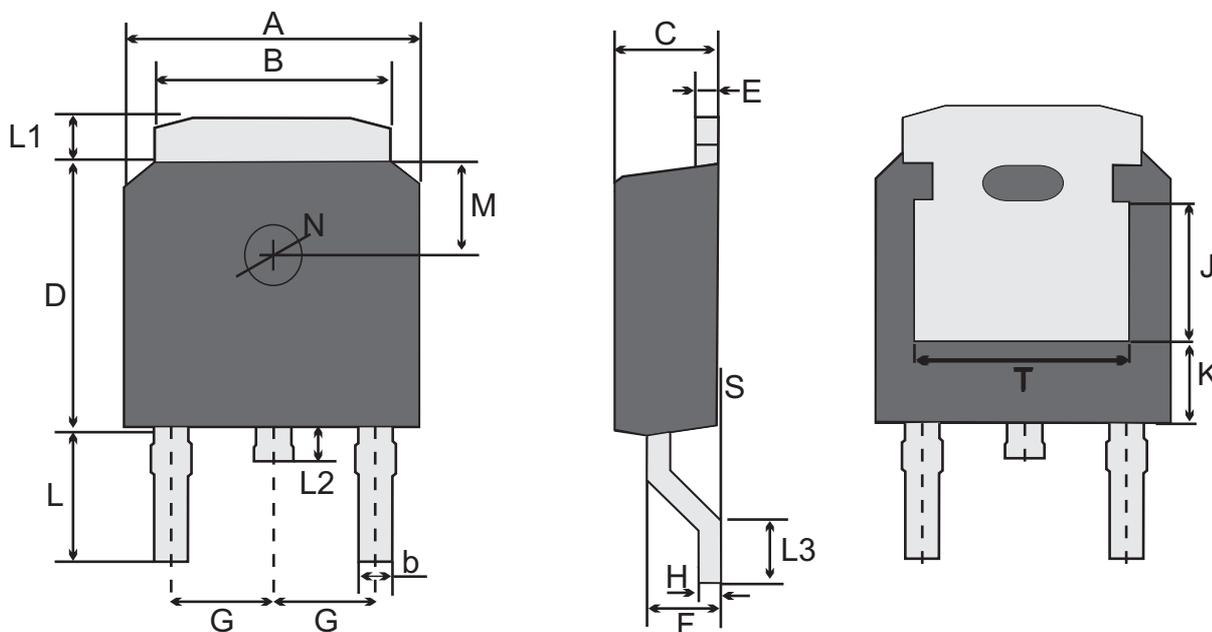


Fig.13 Safe Operating Area





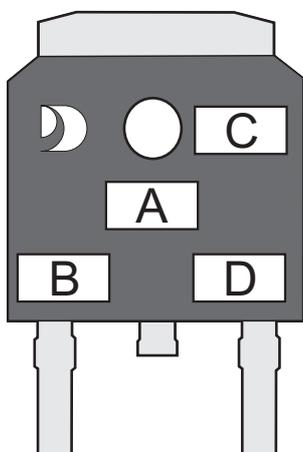
TO-252W(D-PAK) Package Outline Dimensions



TO-252W(D-PAK) mechanical data

UNIT	A	B	b	C	D	E	F	G	H	L	L1	L2	L3	S	M	N	J	K	T	
mm	max	6.7	5.5	0.8	2.5	6.3	0.6	1.8	2.29 TYPICAL	0.55	3.1	1.2	1.0	1.75	0.23	1.8 TYPICAL	1.3 TYPICAL	3.16 ref.	1.80 ref.	4.83 ref.
	typ	6.6	5.3	0.7	2.3	6.1	0.5	1.5		0.50	2.5	1.0	0.6	1.30	0.15					
	min	6.3	5.1	0.3	2.1	5.9	0.4	1.3		0.45	2.7	0.8	0.6	1.00	0.0					
mil	max	264	217	31	98	248	24	71	90 TYPICAL	22	122	47	39	69	9	71 TYPICAL	51 TYPICAL	124 ref.	71 ref.	190 ref.
	typ	260	209	28	90	240	20	59		20	98	39	24	51	6					
	min	248	201	12	83	232	16	51		18	106	31	24	55	0					

MARKING DIAGRAM



- Unmarkable Surfacea
- Marking Composition Field
- A: Marking Area
- B: Lot Code
- C: Additional Information
- D: Date Code (YWW)
- Y: Years(0~9)
- WW: Week



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